Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,782	MITA, KIYOSHI
Examiner	Art Unit

Chris C. Chu

2815

	SEARCHED				
Class	Subclass	Date	Examiner		
361	704	7/13/2005	C.C.		
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	7/13/2005	C.C.		